



Product Change Notification / RMES-05GWNV962

Date:

06-May-2022

Product Category:

Linear Regulators, Power Management - Power Switches

PCN Type:

Manufacturing Change

Notification Subject:

CCB 5127 Initial Notice: Qualification of G700 as a new mold compound material for selected MIC20xxx and MIC5159 device families available in 6L SOT-23 package assembled at STAR assembly site.

Affected CPNs:

[RMES-05GWNV962_Affected_CPN_05062022.pdf](#)

[RMES-05GWNV962_Affected_CPN_05062022.csv](#)

Notification Text:

PCN Status:Initial Notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change:Qualification of G700 as a new mold compound material for selected MIC20xxx and MIC5159 device families available in 6L SOT-23 package assembled at STAR assembly site.

Pre and Post Change Summary:

	Pre Change	Post Change
--	------------	-------------

Assembly Site	Stars Microelectronics (Thailand) Public Company Limited (STAR)	Stars Microelectronics (Thailand) Public Company Limited (STAR)
Wire Material	Au	Au
Die Attach Material	84-1LMISR4	84-1LMISR4
Molding Compound Material	G600	G700
DAP Surface Prep	NiPdAu with Roughened	NiPdAu with Roughened
Lead-frame Material	A194	A194

Impacts to Data Sheet: None

Change Impact: None

Reason for Change: To improve manufacturability by qualifying G700 as a new mold compound material

Change Implementation Status: In Progress

Estimated Qualification Completion Date: July 2022

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

Time Table Summary:

	May 2022					>	July 2022				
Workweek	1 9	2 0	2 1	2 2	2 3		2 7	2 8	2 9	3 0	3 1
Initial PCN Issue Date	x										
Qual Report Availability											x
Final PCN Issue Date											x

Method to Identify Change: Traceability code

Qualification Plan:Please open the attachments included with this PCN labeled as PCN_#_Qual_Plan.

Revision History:May 06, 2022: Issued initial notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

[PCN_RMES-05GWNV962_Qual_Plan.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to receive Microchip PCNs via email please register for our PCN email service at our [PCN home page](#) select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the [PCN FAQ](#) section.

If you wish to change your PCN profile, including opt out, please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

RMES-05GWNV962 - CCB 5127 Initial Notice: Qualification of G700 as a new mold compound material for selected MIC20xxx and MIC5159 device families available in 6L SOT-23 package assembled at STAR assembly site.

Affected Catalog Part Numbers(CPN)

MIC2005A-1YM6-TR
MIC2005A-2YM6-TR
MIC2009A-1YM6-TR
MIC2009A-2YM6-TR
MIC2019A-1YM6-TR
MIC2005-0.5YM6-TR
MIC2005-0.8YM6-TR
MIC2005-1.2YM6-TR
MIC2005M-0.5YM6-TR
MIC2007YM6-TR
MIC2008YM6-TR
MIC2009YM6-TR
MIC2015-0.5YM6-TR
MIC2015-0.8YM6-TR
MIC2015-1.2YM6-TR
MIC2017YM6-TR
MIC2018YM6-TR
MIC2019YM6-TR
MIC2019A-2YM6-TR
MIC5159-1.8YM6-TR
MIC5159YM6-TR



MICROCHIP

QUALIFICATION PLAN SUMMARY

PCN #: RMES-05GWNV962

**Date:
April 28, 2022**

Qualification of G700 as a new mold compound material for selected MIC20xxx and MIC5159 device families available in 6L SOT-23 package assembled at STAR assembly site.

Purpose: Qualification of G700 as a new mold compound material for selected MIC20xxx and MIC5159 device families available in 6L SOT-23 package assembled at STAR assembly site.

<u>Misc.</u>	Assembly site	STAR
	BD Number	BD-000674 Rev.01
	MP Code (MPC)	28805Y6AXA02
	Part Number (CPN)	MIC5159YM6-TR
	MSL information	MSL-1
	Assembly Shipping Media (T/R, Tube/Tray)	T/R
	Base Quantity Multiple (BQM)	3,000 units
	CCB No.	5127
<u>Lead-Frame</u>	Paddle size	41x72 mils
	Material	A194
	DAP Surface Prep	NiPdAu with Roughened
	Treatment	RT+UPG
	Process (Stamped/Etched)	STAMP
	Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	No
	Part Number	07S4172ST00
	Lead frame Thickness	6 mil
	Lead Plating	PPF
	Strip Size	270x83 mm
	Strip Density	960 units
<u>Bond Wire</u>	Material	Au
<u>Die Attach</u>	Part Number	84-1LMISR4
	Conductive	Yes
<u>MC</u>	Part Number	G700
<u>PKG</u>	PKG Type	SOT-23
	Pin/Ball Count	6

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lots	Total Units	Fail Accept Qty	Est. Dur. Days	ATE Test Site	REL Test Site	Special Instructions
Standard Pb-free Solderability	J-STD-002D ; Perform 8 hour steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing. Standard Pb-free: Matte tin/ NiPdAu finish, SAC solder, wetting temp 245°C for both SMD & through hole packages.	22	5	1	27	> 95% lead coverage	5		MTAI	Standard Pb-free solderability is the requirement. SnPb solderability (backward solderability-SMD reflow soldering) is required for any plating related changes and highly recommended for other package BOM changes.
Backward Solderability	J-STD-002D ;Perform 8 hours steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing. Backward: Matte tin/ NiPdAu finish, SnPb solder, wetting temp 215°C for SMD.	22	5	1	27	> 95% lead coverage	5		MTAI	
Wire Bond Pull - WBP	Mil. Std. 883-2011	5	0	1	5	0 fails after TC	5		STAR	30 bonds from a min. 5 devices.
Wire Bond Shear - WBS	CDF-AEC-Q100-001	5	0	1	5	0	5		STAR	30 bonds from a min. 5 devices.
Physical Dimensions	Measure per JESD22 B100 and B108	10	0	3	30	0	5		STAR	
External Visual	Mil. Std. 883-2009/2010	All devices prior to submission for qualification testing	0	3	ALL	0	5		STAR/MTAI	

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lots	Total Units	Fail Accept Qty	Est. Dur. Days	ATE Test Site	REL Test Site	Special Instructions
Preconditioning - Required for surface mount devices	+150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec-STD-020E for package type; Electrical test pre and post stress at +25°C. MSL1 @ 260C	231	15	3	738	0	15	STAR	MTAI	Spares should be properly identified. 77 parts from each lot to be used for HAST, uHAST, Temp Cycle test.
HAST	+130°C/85% RH for 96 hours Electrical test pre and post stress at +25°C	77	5	3	246	0	10	STAR	MTAI	Spares should be properly identified. Use the parts which have gone through Pre-conditioning
UHAST	+130°C/85% RH for 96 hrs Electrical test pre and post stress at +25°C	77	5	3	246	0	10	STAR	MTAI	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
Temp Cycle	-65°C to +150°C for 500 cycles. Electrical test pre and post stress at +25°C; 3 gram force WBP, on 5 devices from 1 lot, test following Temp Cycle stress.	77	5	3	246	0	15	STAR	MTAI	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.